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# Design of a Closed-loop System for Neural Networks Analysis through High Density MEAs

# CERBER



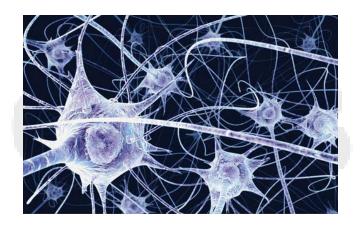
Department of Neuroscience and Brain Technologies
Istituto Italiano di Tecnologia





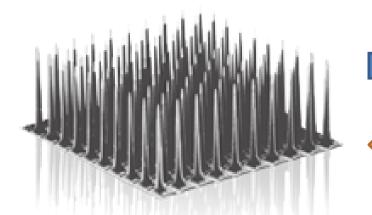


# Objective:



Design a new elaboration tool for neuroscience studies:

- Biological Neural Networks analysis
- Exploiting High-Density Microelectrode Arrays (HDMEAs
- Focus on acquisition-stimulation closed loop application



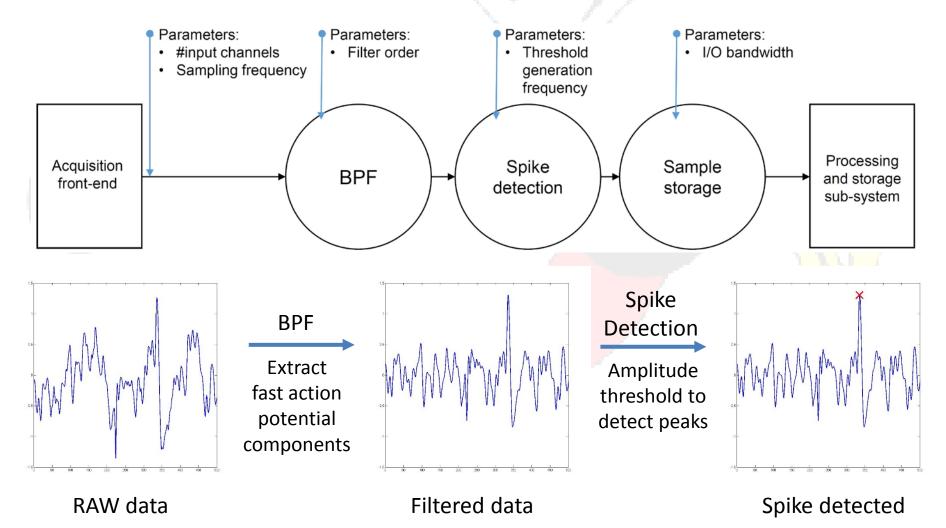
Data

Stimuli

Elaboration System



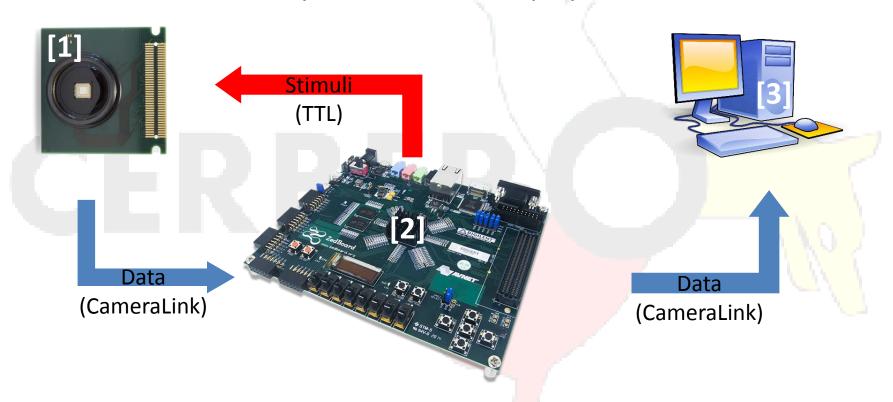
#### Application description:







#### Proposed closed-loop system:

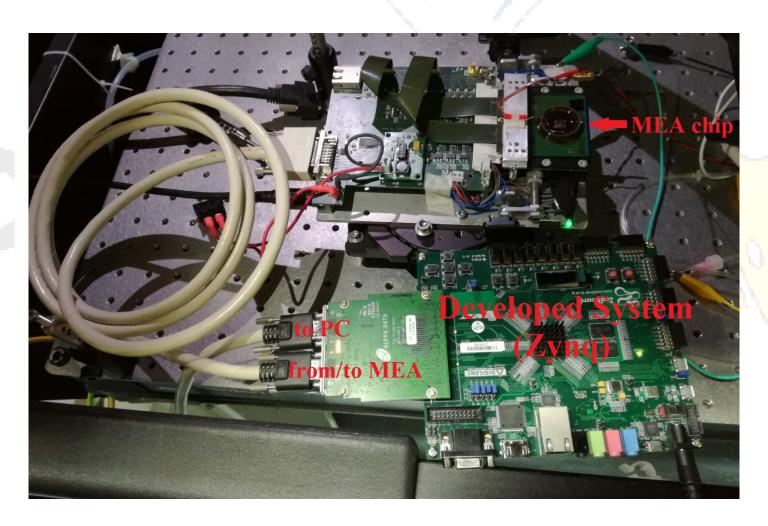


- [1] "3Brain BioCam X," http://www.3brain.com/biocam-system, accessed: 2017-02-07.
- [2] "Zynq-7000 all programmable soc," http://www.xilinx.com/products/silicon-devices/soc/zynq-7000.html, accessed: 2017-02-07.
- [3] "3Brain BrainWave X," http://www.3brain.com/biocam-system, accessed: 2017-02-07.





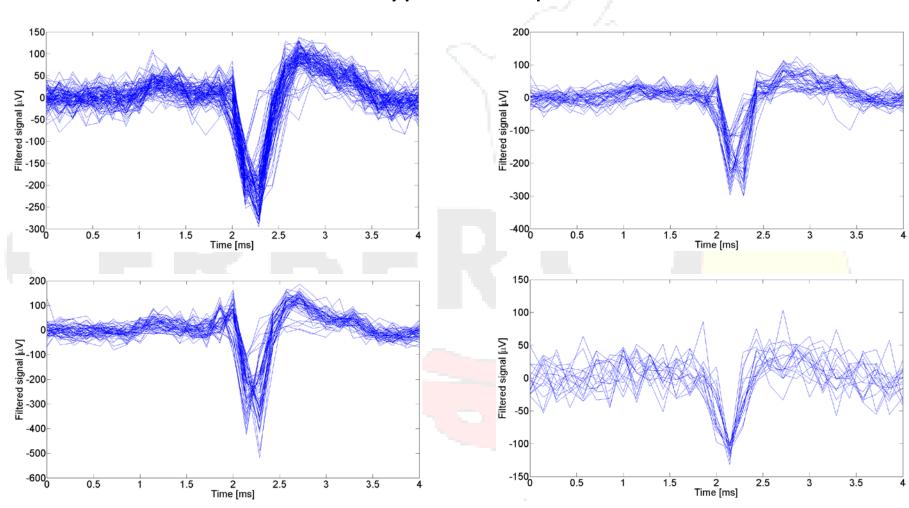
## Prototype:







#### Prototype: Real Spikes



Analysis of neural activity in a mouse retina Detected spikes from 4 different channels at run-time





#### Published papers

G. P. Seu, G. N. Angotzi, G. Tuveri, L. Raffo, L. Berdondini, A. Maccione, and P. Meloni, "On-FPGA real-time processing of biological signals from high-density MEAs: a design space exploration," in 2017 IEEE International Parallel and Distributed Processing Symposium Workshops (IPDPSW), May 2017, pp. 175–183.

URL:http://ieeexplore.ieee.org/stamp/stamp.jsp?tp=&arnumber=7965040&isnumber=7965008

• G. P. Seu, G. N. Angotzi, G. Tuveri, L. Raffo, L. Berdondini, A. Maccione, and P. Meloni, "A closed-loop system for neural networks analysis through high density MEAs," in 2017 13th Conference on Ph.D. Research in Microelectronics and Electronics (PRIME), June 2017, pp. 321–324. URL: http://ieeexplore.ieee.org/stamp/stamp.jsp?tp=&arnumber=7974172&isnumber=7974086